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|-----------------------------------|--|-------------------------|---|-------------|
| <b>Notice of References Cited</b> |  | Application/Control No. | Applicant(s)/Patent Under Reexamination<br>TAKEMAE, YOSHIHIRO |             |
|                                   |  | Examiner<br>Daniel Kim  | Art Unit<br>2185  | Page 1 of 1 |

**U.S. PATENT DOCUMENTS**

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Name              | Classification |
|---|---|--|-----------------|-------------------|----------------|
|   | A | US-2001/0054135                                  | 12-2001         | Matsuda, Yoichi   | 711/167        |
|   | B | US-5,983,331                                     | 11-1999         | Akamatsu et al.   | 711/170        |
|   | C | US-6,085,317                                     | 07-2000         | Smith, Stephen J. | 713/1          |
|   | D | US-6,470,433                                     | 10-2002         | Prouty et al.     | 711/168        |
|   | E | US-2001/0011311                                  | 08-2001         | Takeda, Hiroshi   | 710/61         |
|   | F | US-2003/0070049                                  | 04-2003         | Suzuki, Kei       | 711/151        |
|   | G | US-2002/0159284                                  | 10-2002         | Funaba et al.     | 365/63         |
|   | H | US-5,804,987                                     | 09-1998         | Ogawa et al.      | 326/40         |
|   | I | US-6,415,348                                     | 07-2002         | Mergard et al.    | 710/305        |
|   | J | US-  |                 |                   |                |
|   | K | US-  |                 |                   |                |
|   | L | US-  |                 |                   |                |
|   | M | US-  |                 |                   |                |

**FOREIGN PATENT DOCUMENTS**

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
|   | N |  |                 |         |      |                |
|   | O |  |                 |         |      |                |
|   | P |  |                 |         |      |                |
|   | Q |  |                 |         |      |                |
|   | R |  |                 |         |      |                |
|   | S |  |                 |         |      |                |
|   | T |  |                 |         |      |                |

**NON-PATENT DOCUMENTS**

|   |   |   |
|---|---|---|
| * |   | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|   | U |   |
|   | V |   |
|   | W |   |
|   | X |   |

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